HIGH-SPEED 2K x 8 FourPort™ STATIC RAM

IDT7052S/L

Features

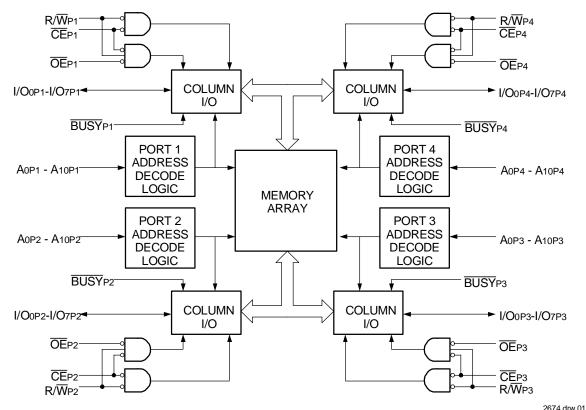
- High-speed access
 - Commercial: 20/25/35ns (max.)
 - Industrial: 25ns (max.)
 - Military: 25/35ns (max.)
- Low-power operation
 - IDT7052S
 - Active: 750mW (typ.)
 - Standby: 7.5mW (typ.)
 - IDT7052L
 - Active: 750mW (typ.)
 - Standby: 1.5mW (typ.)
- True FourPort memory cells which allow simultaneous access of the same memory locations
- Fully asynchronous operation from each of the four ports: P1, P2, P3, P4
- Versatile control for write-inhibit: separate BUSY input to control write-inhibit for each of the four ports

- Battery backup operation—2V data retention
- ◆ TTL-compatible; single 5V (±10%) power supply
- Available in 120 pin and 132 pin Thin Quad Flatpacks and 108 pin PGA
- Military product compliant to MIL-PRF-38535 QML
- Industrial temperature range (-40°C to +85°C) is available for selected speeds
- Green parts available, see ordering information

Description

The IDT7052 is a high-speed $2K \times 8$ FourPortTM Static RAM designed to be used in systems where multiple access into a common RAM is required. This FourPort Static RAM offers increased system performance in multiprocessor systems that have a need to communicate in real time and also offers added benefit for high-speed systems in which multiple access is required in the same cycle.

Functional Block Diagram



2074 UIW 01

JANUARY 2009

The IDT7052 is also designed to be used in systems where on-chip hardware port arbitration is not needed. This part lends itself to those systems which cannot tolerate wait states or are designed to be able to externally arbitrate or withstand contention when all ports simultaneously access the same FourPort RAM location.

The IDT7052 provides four independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. It is the user's responsibility to ensure data integrity when simultaneously accessing the same memory location from all ports. An automatic power down feature, controlled by $\overline{\text{CE}}$, permits the on-chip circuitry of each port to enter a very low power standby power mode.

Fabricated using IDT's CMOS high-performance technology, this FourPort SRAM typically operates on only 750mW of power. Low-power (L) versions offer battery backup data retention capability, with each port typically consuming 50μ W from a 2V battery.

The IDT7052 is packaged in a ceramic 108-pin Pin Grid Array (PGA), 120-pin Thin Quad Flatpack (TQFP) and 132-pin Plastic Quad Flatpack (PQF). Military grade product is manufactured in compliance with the latest revision of MIL-PRF-38535 QML, making it ideally suited to military temperature applications demanding the highest level of performance and reliability.

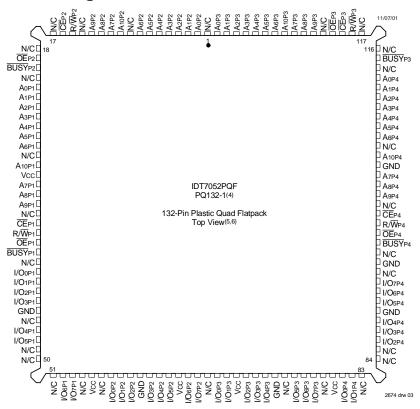
11/07/01

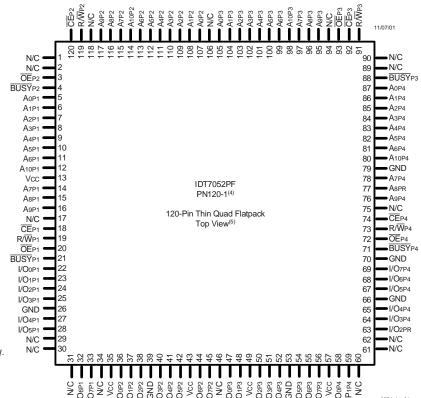
Pin Configurations (1,2,3)

											11/07/01	
81	80	77	74	72	69	68	65	63	60	57	54	
R/W P2	NC	A7 P2	A ₅ P2	Аз Р2	A ₀ P2	Ao P3	Аз Р3	A5 P3	A7 P3	NC	R/W P3	12
84	83	78	76	73	70	67	64	61	59	56	53	
BUSY P2	OE P2	A8 P2	A ₁₀ P ₂	A4 P2	A1 P2	A ₁ P ₃	A ₄ P3	A ₁₀ P3	A8 P3	OE P3	BUSY P3	11
37	86	82	79	75	71	66	62	58	55	51	50	
A2 P1	A ₁ P1	CE	A9 P2	A ₆ P2	A ₂ P2	A ₂ P3	A6 P3	A9 P3	CE P3	A1 P4	A ₂ P4	10
90	88	85		•	•	•	•	•	52	49	47	
A5 P1	Аз Р1	Ao P1							Ao P4	Аз Р4	A5 P4	09
92	91	89	1						48	46	45	
A10 P1	A6 P1	A ₄ P1							A ₄ P4	A6 P4	A10 P4	80
95	94	93							44	43	42	
A8 P1	A7 P1	Vcc				7052G 08-1 ⁽⁴⁾			GND	A ₇ P4	A8 P4	07
96	97	98	1		GIC	J8-1(4)			39	40	41	
A9 P1	NC	CE P1				Pin PGA View ⁽⁵⁾			CE P4	NC	A9 P4	06
99	100	102							35	37	38	
R/W P1	OE P1	I/O ₀ P1							GND	OE P4	R/W P4	05
101	103	106	1						31	34	36	
BUSY P1	I/O ₁ P1	GND							GND	I/O7 P4	BUSY P4	04
104	105	1	4	8	12	17	21	25	28	32	33	
I/O ₂ P1	I/O3 P1	I/O ₆ P1	Vcc	GND	Vcc	Vcc	GND	Vcc	I/O ₂ P4	I/O ₅ P4	I/O ₆ P4	03
107	2	5	7	10	13	16	19	22	24	29	30	
I/O4 P1	I/O7 P1	I/O ₀ P2	I/O ₂ P2	I/O4 P2	I/O ₆ P2	I/O ₁ P3	I/O3 P3	I/O ₅ P3	I/O7 P3	I/O3 P4	I/O4 P4	02
108	3	6	9	11	14	15	18	20	23	26	27	
I/O ₅ P1	NC	I/O ₁ P2	I/O3 P2	I/O ₅ P2	I/O7 P2	I/O ₀ P3	I/O ₂ P3	I/O ₄ P3	I/O ₆ P3	I/O ₀ P4	I/O ₁ P4	01
Α	В	С	D	Е	F	G	Н	J	K	L	М	•
											2674 drw (02
X												

- 1. All Vcc pins must be connected to the power supply.
- 2. All GND pins must be connected to the ground supply.
- 3. Package body is approximately 1.21 in x 1.21 in x .16 in.
- 4. This package code is used to reference the package diagram.
- 5. This text does not indicate orientation of the actual part-marking.

Pin Configurations (1,2,3) (con't.)





- 1. All Vcc pins must be connected to the power supply.
- 2. All GND pins must be connected to the ground supply.
- 3. PQ132-1 package body is approximately .95 in x .95 in x .14 in.
 - PN120-1 package body is approximately $14mm \times 14mm \times 1.4mm$.
- 4. This package code is used to reference the package diagram.
- 5. This text does not indicate orientation of the actual part-marking
- The side of the package containing pin1 may have a bevelled edge in place of the indicator dot..

Pin Configurations (1,2)

Symbol	Pin Name
A0 P1 - A10 P1	Address Lines - Port 1
A0 P2 - A10P2	Address Lines - Port 2
A0 P3 - A10 P3	Address Lines - Port 3
A0 P4 - A10 P4	Address Lines - Port 4
I/Oo P1 - I/O7 P1	Data I/O - Port 1
I/Oo P2 - I/O7 P2	Data I/O - Port 2
I/Oo P3 - I/O7 P3	Data I/O - Port 3
I/O0 P4 - I/O7 P4	Data I/O - Port 4
R/W P1	Read/Write - Port 1
R/W P2	Read/Write - Port 2
R/W P3	Read/Write - Port 3
R/W P4	Read/Write - Port 4
GND	Ground
CE P1	Chip Enable - Port 1
CE P2	Chip Enable - Port 2
CE P3	Chip Enable - Port 3
CE P4	Chip Enable - Port 4
OE P1	Output Enable - Port 1
OE P2	Output Enable - Port 2
OE P3	Output Enable - Port 3
OE P4	Output Enable - Port 4
BUSY P1	Write Disable - Port 1
BUSY P2	Write Disable - Port 2
BUSY P3	Write Disable - Port 3
BUSY P4	Write Disable - Port 4
Vcc	Power

NOTES:

- 1. All Vcc pins must be connected to the power supply.
- 2. All GND pins must be connected to the ground supply

Capacitance⁽¹⁾

 $(TA = +25^{\circ}C, f = 1.0MHz) TQFP only$

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
CIN	Input Capacitance	VIN = 0V	9	pF
Соит	Output Capacitance	Vout = 0V	10	pF

NOTES:

- This parameter is determined by device characterization but is not production tested.
- 3dV references the interpolated capacitance when the input and the output signals switch from 0V to 3V or from 3V to 0V.

Absolute Maximum Ratings(1)

Symbol	Rating	Commercial & Industrial	Military	Unit
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
TBIAS	Temperature Under Bias	-55 to +125	-65 to +135	۰C
Tstg	Storage Temperature	-65 to +150	-65 to +150	۰C
Іоит	DC Output Current	50	50	mA

NOTES:

2674 tbl 02

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. VTERM must not exceed Vcc + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to \leq 20mA for the period of VTERM \geq Vcc + 10%.

Maximum Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	Vcc
Military	-55°C to+125°C	0V	5.0V <u>+</u> 10%
Commercial	0°C to +70°C	0V	5.0V <u>+</u> 10%
Industrial	-40°C to +85°C	0V	5.0V <u>+</u> 10%

NOTES:

2674 tbl 01

2674 tbl 03

2674 tbl 04

1. This is the parameter TA. This is the "instant on" case temperature.

Recommended DC Operating Conditions

GOTTATETOTIS							
Symbol	Parameter	Min.	Тур.	Max.	Unit		
Vcc	Supply Voltage	4.5	5.0	5.5	٧		
GND	Ground	0	0	0	V		
VIH	Input High Voltage	2.2	_	6.0(2)	٧		
VIL	Input Low Voltage	-0.5 ⁽¹⁾		0.8	V		

NOTES

- 1. $Vil \ge -1.5V$ for pulse width less than 10ns.
- 2. VTERM must not exceed Vcc + 10%.

2674 tbl 05

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range $^{(1,5)}$ (Vcc = 5.0V ± 10%)

					7052X20 Com'l Only		7052X25 Com'l, Ind & Military		7052X35 Com'l & Military		
Symbol	Parameter	Condition	Versi	on	Typ. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Typ. ⁽²⁾	Max.	Unit
Icc1	Operating Power Supply Current (All Ports Active)	\overline{CE} = VIL Outputs Disabled $f = 0^{(3)}$	COM'L.	S L	150 150	300 250	150 150	300 250	150 150	300 250	mA
	(All Folis Active)	1 = 0.49	MIL. & IND.	S L	_	_	150 150	360 300	150 150	360 300	
ICC2	Dynamic Operating Current (All Ports Active)	CE = VIL Outputs Disabled f = fMax ⁽⁴⁾	COM'L.	S L	240 210	370 325	225 195	350 305	210 180	335 290	mA
	(All Poits Active)	Γ = IMAX ^(*)	MIL. & IND.	S L		11	225 195	400 340	210 180	395 330	
ISB	Standby Current (All Ports - TTL Level	$\overline{CE} = VIH$ $f = f_{MAX}^{(4)}$	COM'L.	S L	70 60	95 80	45 40	85 70	40 35	75 60	mA
	Inputs)		MIL. & IND.	S L		11	45 40	115 85	40 35	110 80	
ISB1	Full Standby Current (All Ports - All CMOS	All Ports CE ≥ Vcc - 0.2V	COM'L.	S L	1.5 0.3	15 1.5	1.5 0.3	15 1.5	1.5 0.3	15 1.5	mA
	Level Inputs)	$V_{IN} \ge V_{CC} - 0.2V \text{ or } V_{IN} \le 0.2V, f = 0^{(3)}$	MIL. & IND.	S L		_	1.5 0.3	30 4.5	1.5 0.3	30 4.5	

NOTES: 2674 tbl 06

- 1. 'X' in part number indicates power rating (S or L).
- 2. Vcc = 5V, TA = +25°C and are not production tested.
- 3. f = 0 means no address or control lines change.
- 4. At f = fmax, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/trc, and using "AC Test Conditions" of input levels of GND to 3V.
- 5. For the case of one port, divide the appropriate current above by four.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range ($Vcc = 5.0V \pm 10\%$)

			7052S		7052L		
Symbol	Parameter	Test Conditions	Min.	Max.	Min.	Max.	Unit
LI	Input Leakage Current ⁽¹⁾	Vcc = 5.5V, $Vin = 0V$ to Vcc	-	10	_	5	μΑ
ILO	Output Leakage Current	\overline{CE} = ViH, Vout = 0V to Vcc	_	10	_	5	μΑ
Vol	Output Low Voltage	Iol = 4mA	-	0.4	-	0.4	V
Voh	Output High Voltage	Ioн = -4mA	2.4	_	2.4	_	V

NOTE:

1. At $Vcc \le 2.0V$ input leakages are undefined.

2674 tbl 07

Data Retention Characteristics Over All Temperature Ranges⁽⁴⁾

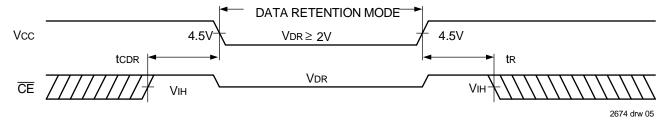
(L Version Only) VLC = 0.2V, VHC = VCC - 0.2V

Ì	, , , , , , , , , , , , , , , , , , ,	I			(4)		
Symbol	Parameter	Test Condition	on	Min.	Typ. ⁽¹⁾	Max.	Unit
VDR	Vcc for Data Retention	Vcc = 2V		2.0	-	-	V
ICCDR	Data Retention Current	CE ≥ VHC	Com'l.	_	25	600	μA
		VIN > VHC or < VLC	Mil. & Ind.	_	25	1800	
tcdr ⁽³⁾	Chip Deselect to Data Retention Time			0	_	_	ns
tR ⁽³⁾	Operation Recovery Time			trc ⁽²⁾	_	-	ns

NOTES:

- 1. Vcc = 2V, TA = +25°C
- 2. trc = Read Cycle Time
- 3. This parameter is guaranteed but not production tested.
- 4. Industrial temperature: For other speeds, packages and powers contact your sales office.

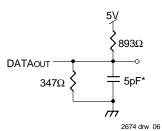
Low Vcc Data Retention Waveform



AC Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1 and 2
	2674 tbl 08b

DATAOUT 347Ω 30pF



2674 tbl 08a

Figure 1. AC Output Test Load

Figure 2. Output Test Load (for tLz, tHz, twz, tow) *Including scope and jig

2674 tbl 09

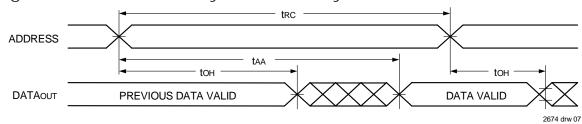
AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽³⁾

		7052X20 Com'l Only		7052X25 Com'l, Ind & Military		7052X35 Com'l & Military			
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit	
READ CYCLE									
trc	Read Cycle Time	20	_	25	_	35	_	ns	
taa	Address Access Time	_	20	_	25	_	35	ns	
tace	Chip Enable Access Time	_	20		25	_	35	ns	
taoe	Output Enable Access Time	_	10		15	_	25	ns	
tон	Output Hold from Address Change	0	_	0	_	0	_	ns	
tLz	Output Low-Z Time ^(1,2)	5		5		5		ns	
tHZ	Output High-Z Time ^(1,2)	_	12		15	ļ	15	ns	
t PU	Chip Enable to Power Up Time ⁽²⁾	0	_	0	_	0	_	ns	
tPD	Chip Disable to Power Down Time ⁽²⁾		20		25		35	ns	

NOTES:

- 1. Transition is measured 0mV from Low or High-Impedance voltage with the Output Test Load (Figure 2)
- 2. This parameter is guaranteed by device characterization but is not production tested.
- 3. 'X' in part number indicates power rating (S or L)

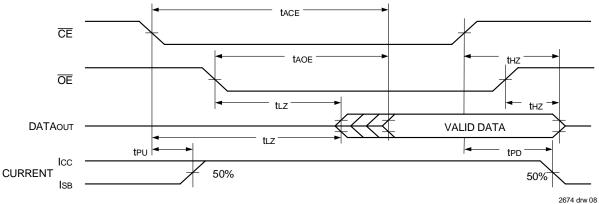
Timing Waveform of Read Cycle No. 1, Any Port(1)



NOTES:

1. $R/\overline{W} = V_{IH}$, $\overline{OE} = V_{IL}$ and $\overline{CE} = V_{IL}$.

Timing Waveform of Read Cycle No. 2, Any Port (1,2)



- 1. $R/\overline{W} = V_{IH}$ for Read Cycles.
- 2. Addresses valid prior to or coincident with $\overline{\text{CE}}$ transition LOW.

2674 tbl 10

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage⁽⁷⁾

		7052X20 Com'l Only		7052X25 Com'l & Military		7052X35 Com'l & Military		
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	Unit
WRITE CYCLE	=							
twc	Write Cycle Time	20		25		35		ns
tew	Chip Enable to End-of-Write ⁽³⁾	15		20		30		ns
taw	Address Valid to End-of-Write	15		20		30		ns
tas	Address Set-up Time	0		0		0		ns
twp	Write Pulse Width ⁽³⁾	15		20		30		ns
twr	Write Recovery Time	0		0		0		ns
tow	Data Valid to End-of-Write	15		15	_	20		ns
tHZ	Output High-Z Time ^(1,2)		15		15		15	ns
tDH	Data Hold Time	0		0		0		ns
twz	Write Enable to Output in High-Z ^(1,2)		12	_	15		15	ns
tow	Output Active from End-of-Write ^(1,2)	0		0		0		ns
twdd	Write Pulse to Data Delay ⁽⁴⁾		35	_	45	_	55	ns
twdd	Write Data Valid to Read Data Delay ⁽⁴⁾	_	30	_	35	_	45	ns
BUSY INPUT	TIMING							
twB	Write to BUSY ⁽⁵⁾	0		0		0		ns
twн	Write Hold After BUSY ⁽⁶⁾	15	_	15	_	20		ns

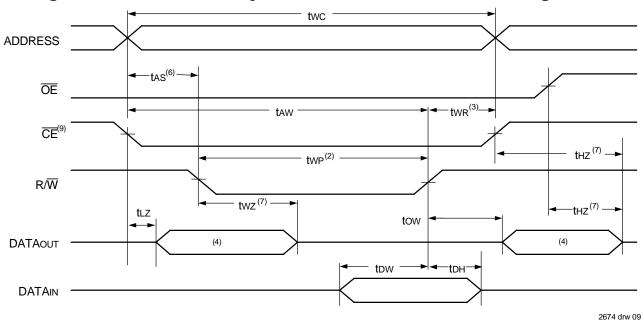
NOTES:

1. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).

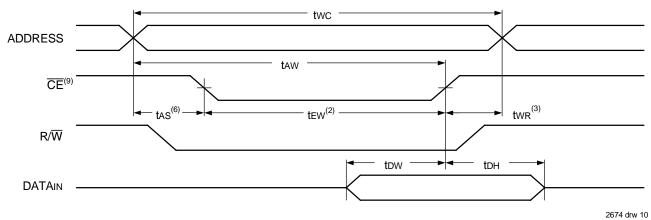
- 2. This parameter is guaranteed by device characterization but is not production tested.
- 3. If $\overline{OE} = V_{IL}$ during a R/W controlled write cycle, the write pulse width must be the larger of two or (twz + tow) to allow the I/O drivers to turn off data to be placed on the bus for the required tow. If $\overline{OE} = VIH$ during an R/W controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp. Specified for \overline{OE} = VIH (refer to "Timing Waveform of Write Cycle", Note 8).
- 4. Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write with Port-to-Port Read".
- 5. To ensure that the write cycle is inhibited on port "A" during contention from Port "B". Port "A" may be any of the four ports and Port "B" is any other port.

 6. To ensure that a write cycle is completed on port "A" after contention from Port "B". Port "A" may be any of the four ports and Port "B" is any other port.
- 7. 'X' in part number indicates power rating.

Timing Waveform of Write Cycle No. 1, R/W Controlled Timing (5,8)

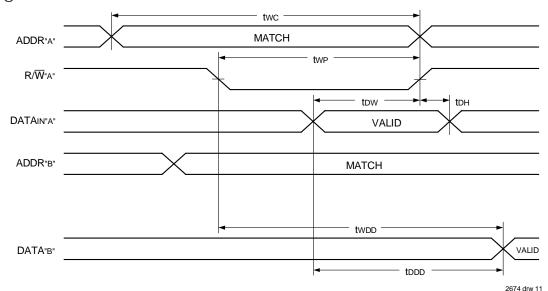


Timing Waveform of Write Cycle No. 2, CE Controlled Timing (1, 5)



- 1. R/\overline{W} or \overline{CE} = ViH during all address transitions.
- 2. A write occurs during the overlap (tew or twp) of a \overline{CE} = V_{IL} and a R/ \overline{W} = V_{IL}.
- 3. two is measured from the earlier of \overline{CE} or $R/\overline{W} = VIH$ to the end of write cycle.
- 4. During this period, the I/O pins are in the output state, and input signals must not be applied.
- 5. If the $\overline{CE} = VIL$ transition occurs simultaneously with or after the $R/\overline{W} = VIL$ transition, the outputs remain in the High-impedance state.
- 6. Timing depends on which enable signal is asserted last, $\overline{\text{CE}}$ or R/\overline{W} .
- 7. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2). This parameter is guaranteed but is not production tested.
- 8. If $\overline{OE} = V_{IL}$ during a $R\overline{W}$ controlled write cycle, the write pulse width must be the larger of twp or (twz + tow) to allow the I/O drivers to turn off data to be placed on the bus for the required tow. If $\overline{OE} = V_{IH}$ during an $R\overline{W}$ controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified twp.

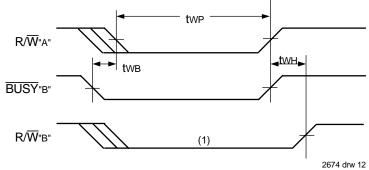
Timing Waveform of Write with Port-to-Port Read^(1,2,3)



NOTES:

- 1. Assume \overline{BUSY} input = VIH and \overline{CE} = VIL for the writing port.
- 2. $\overline{OE} = V_{IL}$ for the reading ports.
- 3. All timing is the same for left and right ports. Port "A" may be either of the four ports and Port "B" is any other port.

Timing Waveform of Write with **BUSY** Input



NOTES:

1. $\overline{\text{BUSY}}$ is asserted on Port "B" blocking R/ $\overline{\text{W}}$ "B" until $\overline{\text{BUSY}}$ "B" goes HIGH.

Functional Description

The IDT7052 provides four ports with separate control, address, and I/O pins that permit independent access for reads or writes to any location in memory. These devices have an automatic power down feature controlled by $\overline{\text{CE}}$. The $\overline{\text{CE}}$ controls on-chip power down circuitry that permits the respective port to go into standby mode when not selected ($\overline{\text{CE}}$ = VIH). When a port is enabled, access to the entire memory array is permitted. Each port has its own Output Enable control ($\overline{\text{OE}}$). In the read mode, the port's $\overline{\text{OE}}$ turns on the output drivers when set LOW. READ/WRITE conditions are illustrated in the table below.

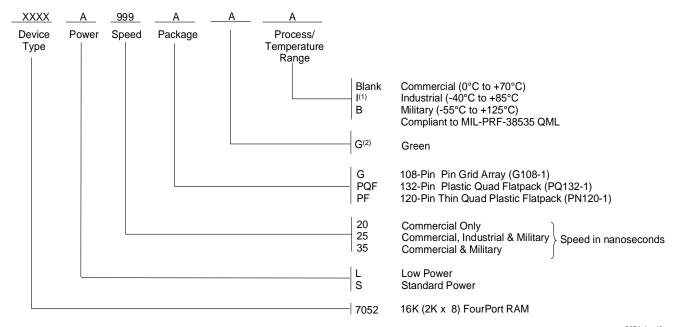
Truth Table I – Read/Write Control⁽³⁾

Any Port ⁽¹⁾				
R/W	ΖĒ	ŌĒ	D0-7	Function
Х	Н	Χ	Z	Port Deselected: Power-Down
Х	Н	Х	Z	CEP1=CEP2=CEP3=CEP4=VH Power Down Mode ISB or ISB1
L	L	Х	DATAIN	Data on port written into memory ⁽²⁾
Н	L	L	DATAout	Data in memory output on port
Х	Χ	Н	Z	Outputs Disabled

2674 tbl 11

- 1. "H" = VIH, "L" = VIL, "X" = Don't Care, "Z "= High Impedance
- 2. If $\overline{\text{BUSY}} = \text{VIL}$, write is blocked.
- 3. For valid write operation, no more than one port can write to the same address location at the same time.

Ordering Information



NOTE: 2674 drw 13

- 1. Industrial temperature range is available. For specific speeds, packages and powers contact your sales office.
- 2. Green parts available. For specific speeds, packages and powers contact your local sales office.

Datasheet Document History

1/18/99: Initiated datasheet document history

Converted to new format

Cosmetic typographical corrections Added additional notes to pin configurations

6/4/99: Changed drawing format

Page1 Corrected DSC number

11/10/99: Replaced IDT logo

11/18/99: Page 10 Fixed typo in caption for BUSY Input waveform 5/23/00: Page 4 Increased storage temperature parameter

Clarified TA parameter

Page 5 DC Electrical parameters-changed wording from "open" to "disabled"

Changed ±200mV to 0mV in notes

10/22/01: Pages 2 & 3 Added date revision for pin configurations

Page 5, 7 & 8 Added Industrial temp to column heading for 25ns speed to DC & AC Electrical Characteristics

Page 11 Added Industrial temp offering to 25ns ordering information Page 4, 5, 7 & 8 Removed Industrial temp footnote from all tables

Page 1 & 11 Replace TM logo with ® logo

07/24/06: Page 1 Added green availability to features

Page 11 Added green indicator to ordering information

01/19/09: Page 11 Removed "IDT" from orderable part number



CORPORATE HEADQUARTERS

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